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(54) **MASK FOR LIGHT EXPOSURE AND
METHOD FOR MANUFACTURING LIQUID
CRYSTAL DISPLAY APPARATUS
EMPLOYING SAME**

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(57) **ABSTRACT**

Light exposure areas **103** and light masking areas **104** in a sole reticle are arrayed in alternation to one another in both the longitudinal and transverse directions. Substrate is exposed to light by multi-domain light exposure using this reticle so that the respective areas of the reticle exposed to light with respective shots A to B, B to C . . . , N to M are not adjacent to one another in the boundary portions of the reticle shifted for executing the respective shots, thus relaxing the difference in illuminance between the respective shots and the difference in finish of the boundary portions of the shots, such differences becoming imperceptible to human eyes upon displaying liquid crystal display apparatus.

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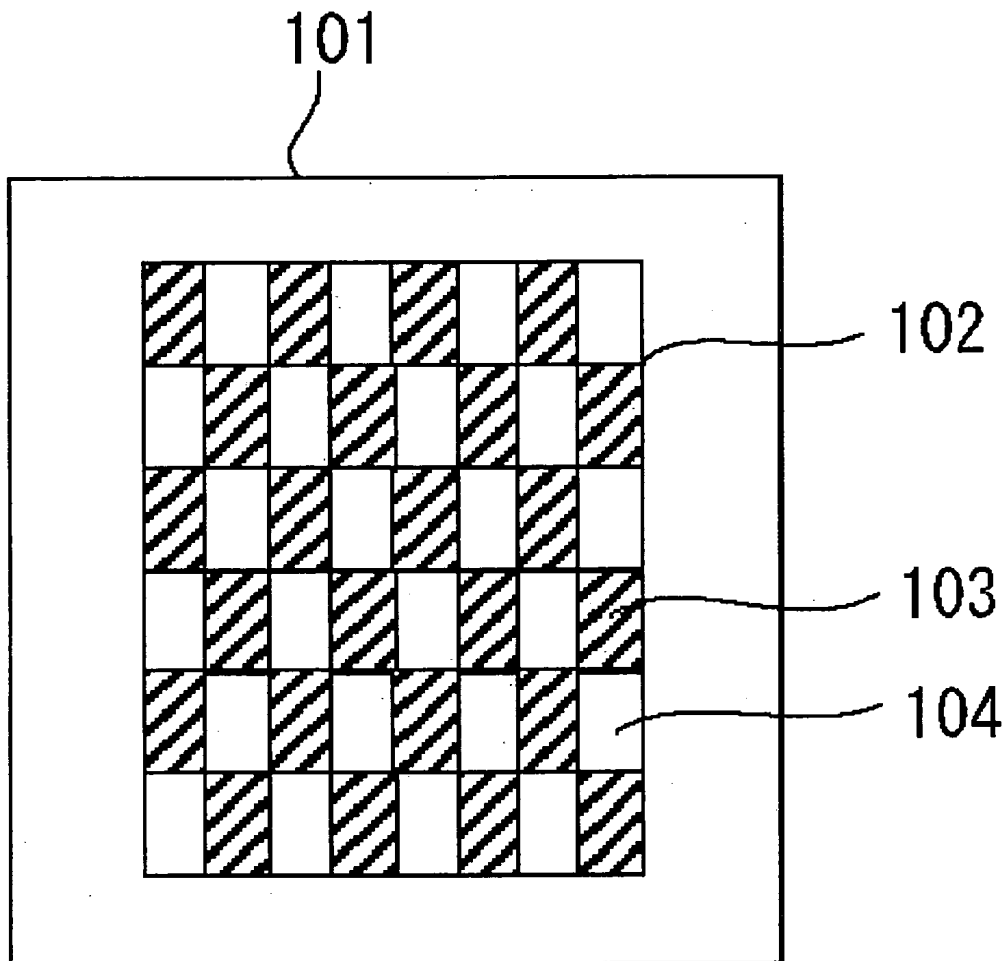


FIG . 1

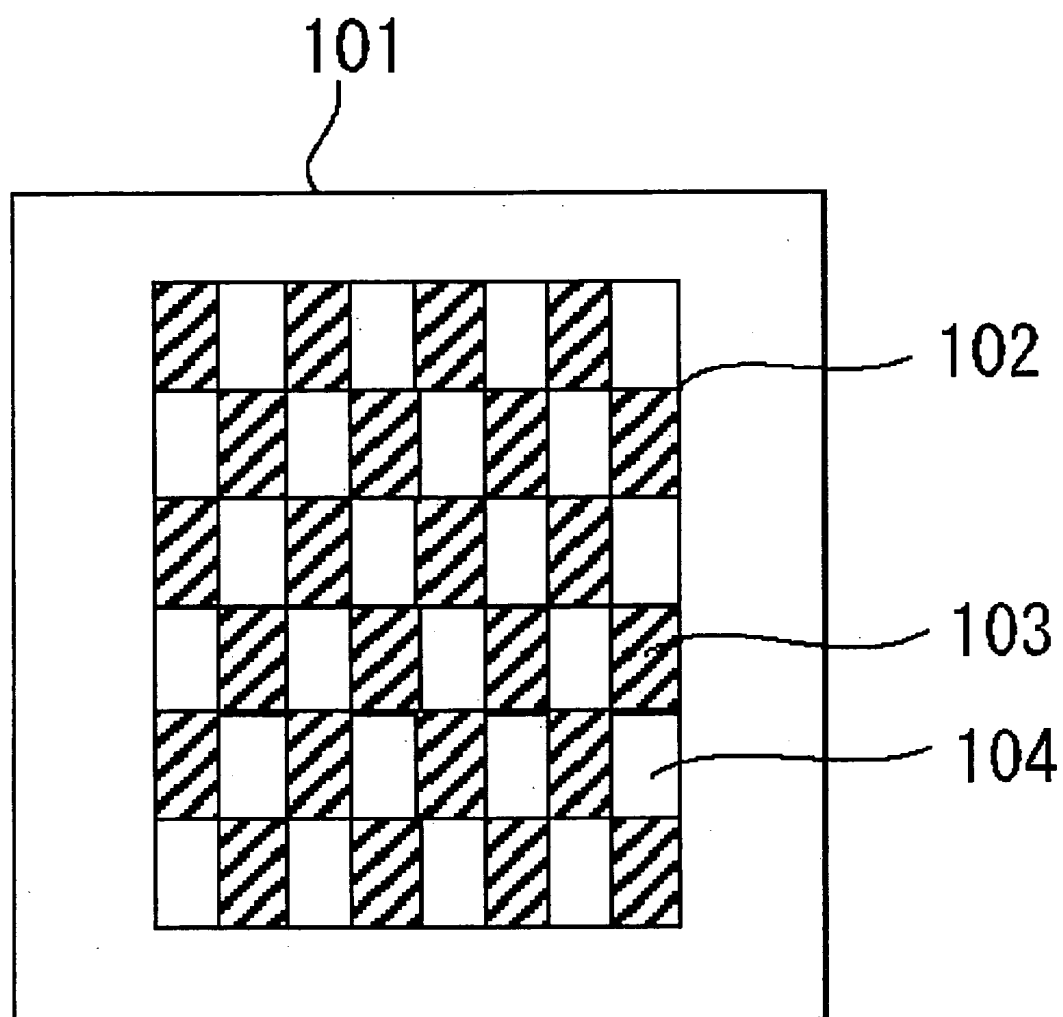


FIG . 2a

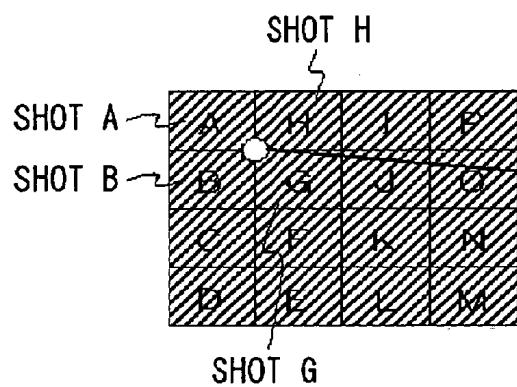


FIG . 2b

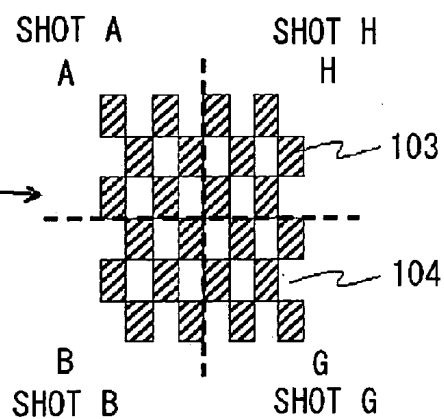


FIG . 3a

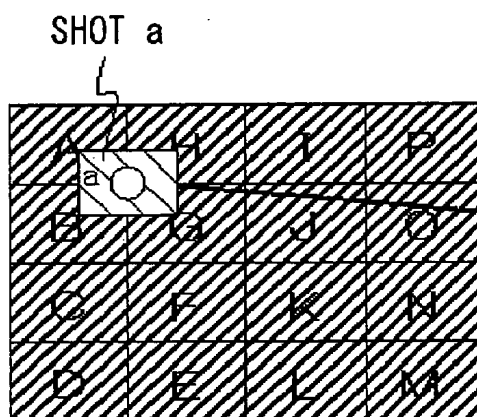


FIG . 3b

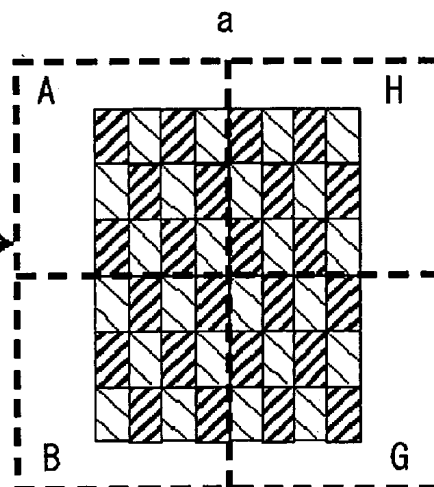


FIG . 4a

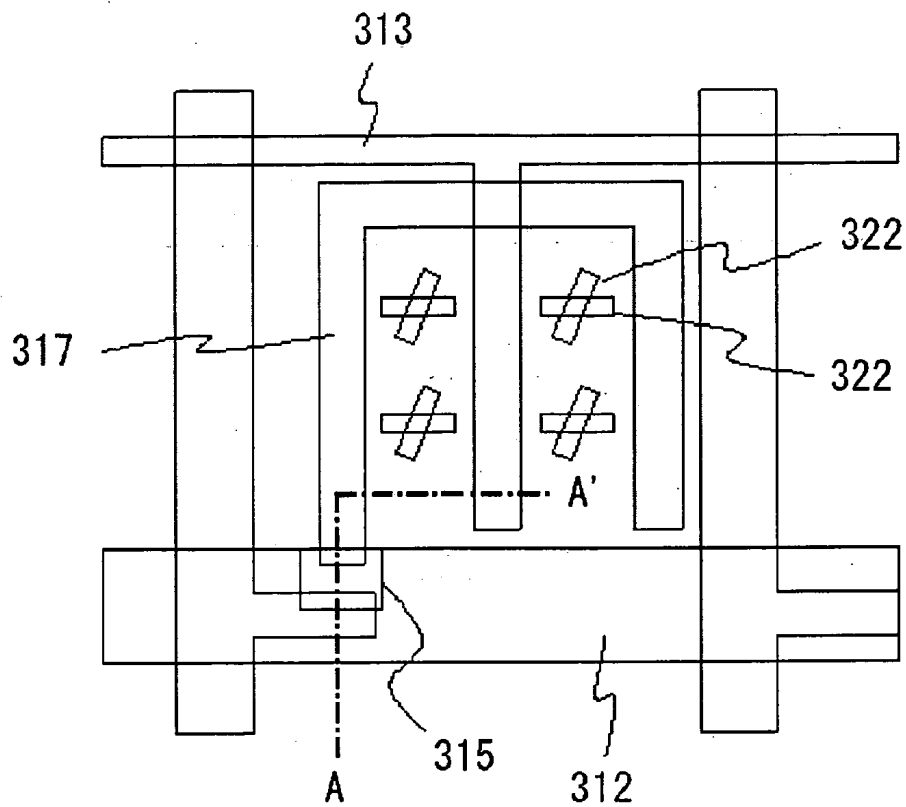


FIG . 4b

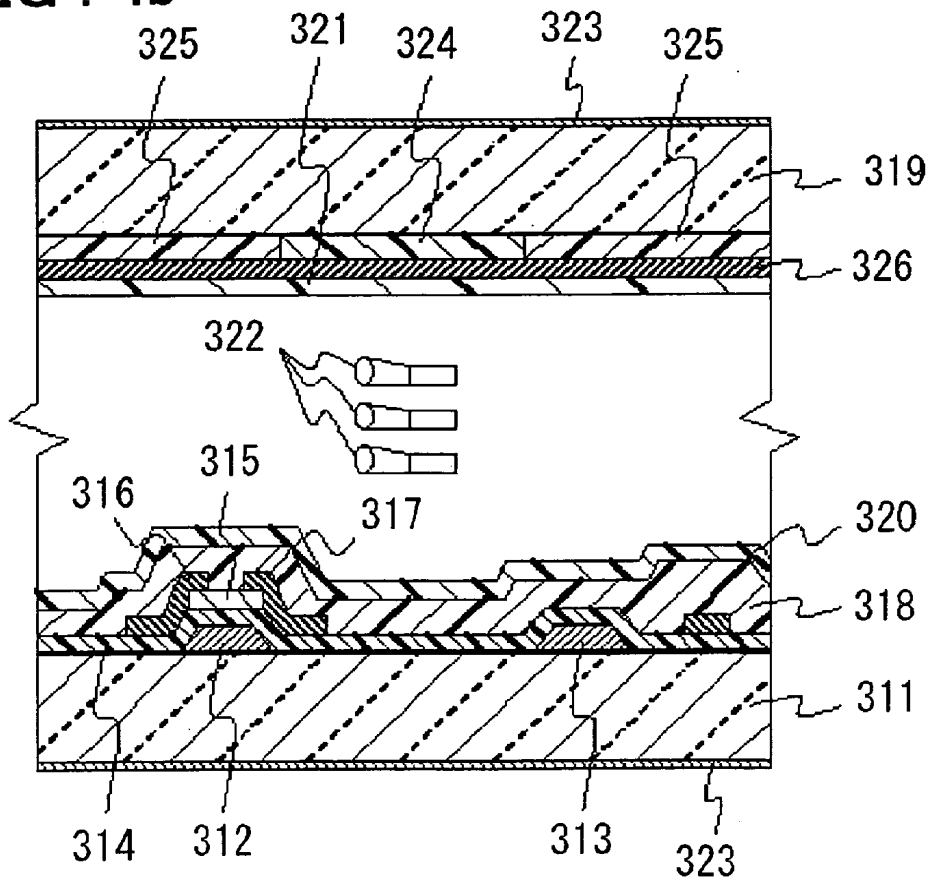


FIG . 5a

BOUNDARY BETWEEN
SHOTS A AND H

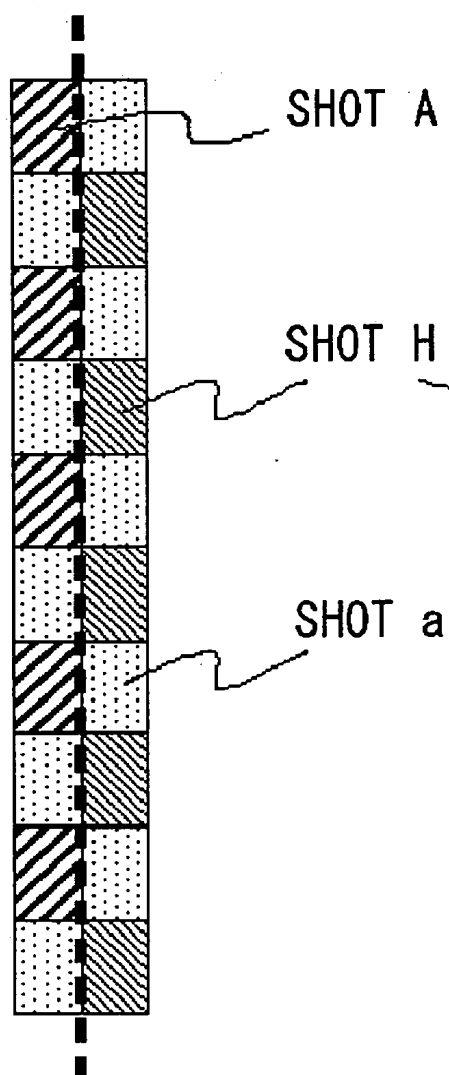


FIG . 5b

BOUNDARY BETWEEN
SHOTS A AND H

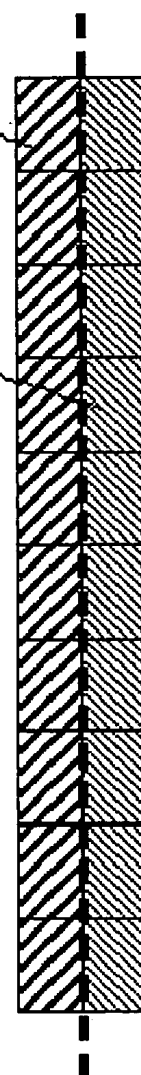


FIG . 6a

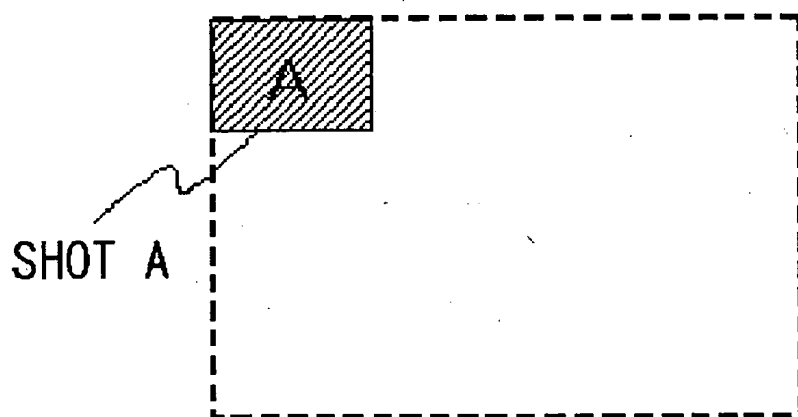


FIG . 6b

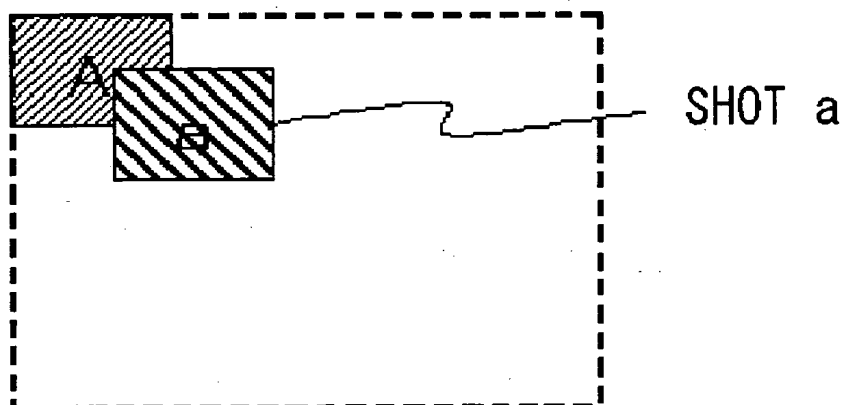


FIG . 6c

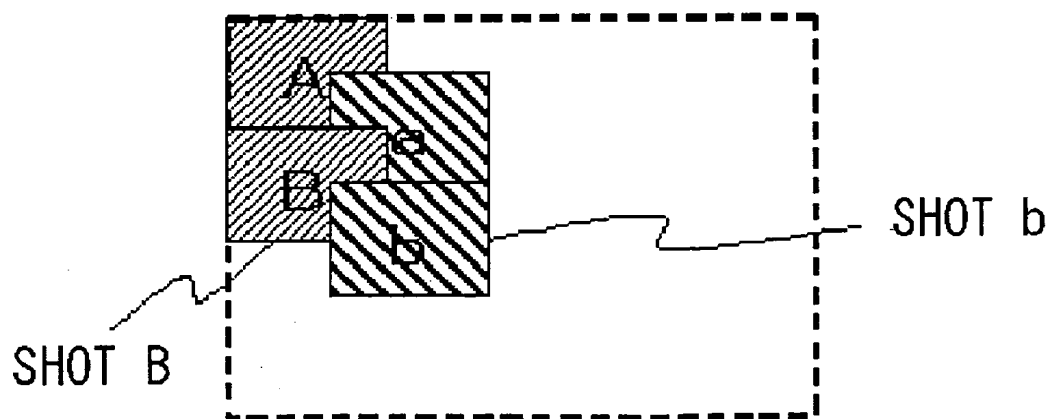


FIG . 7 PRIOR ART

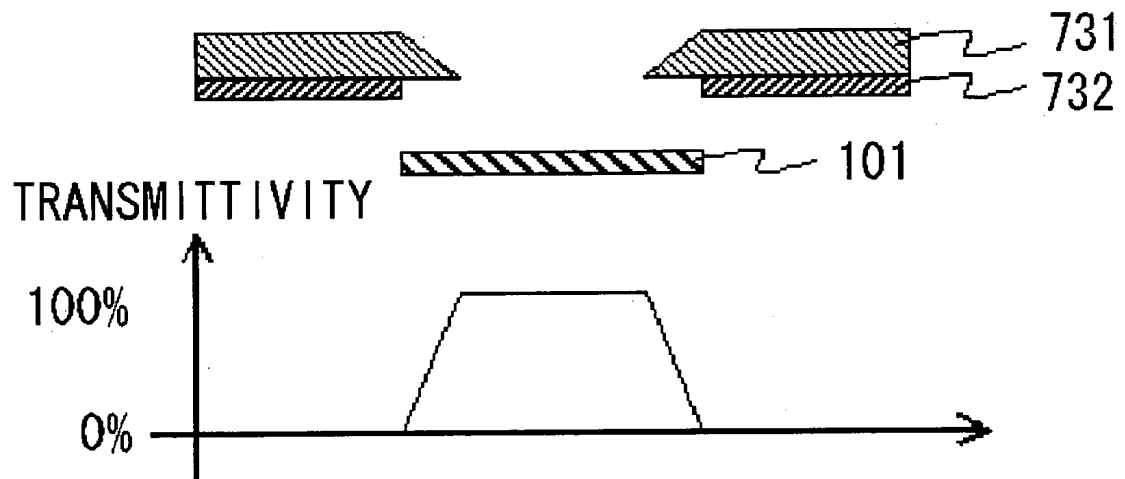


FIG. 8

PRIOR ART

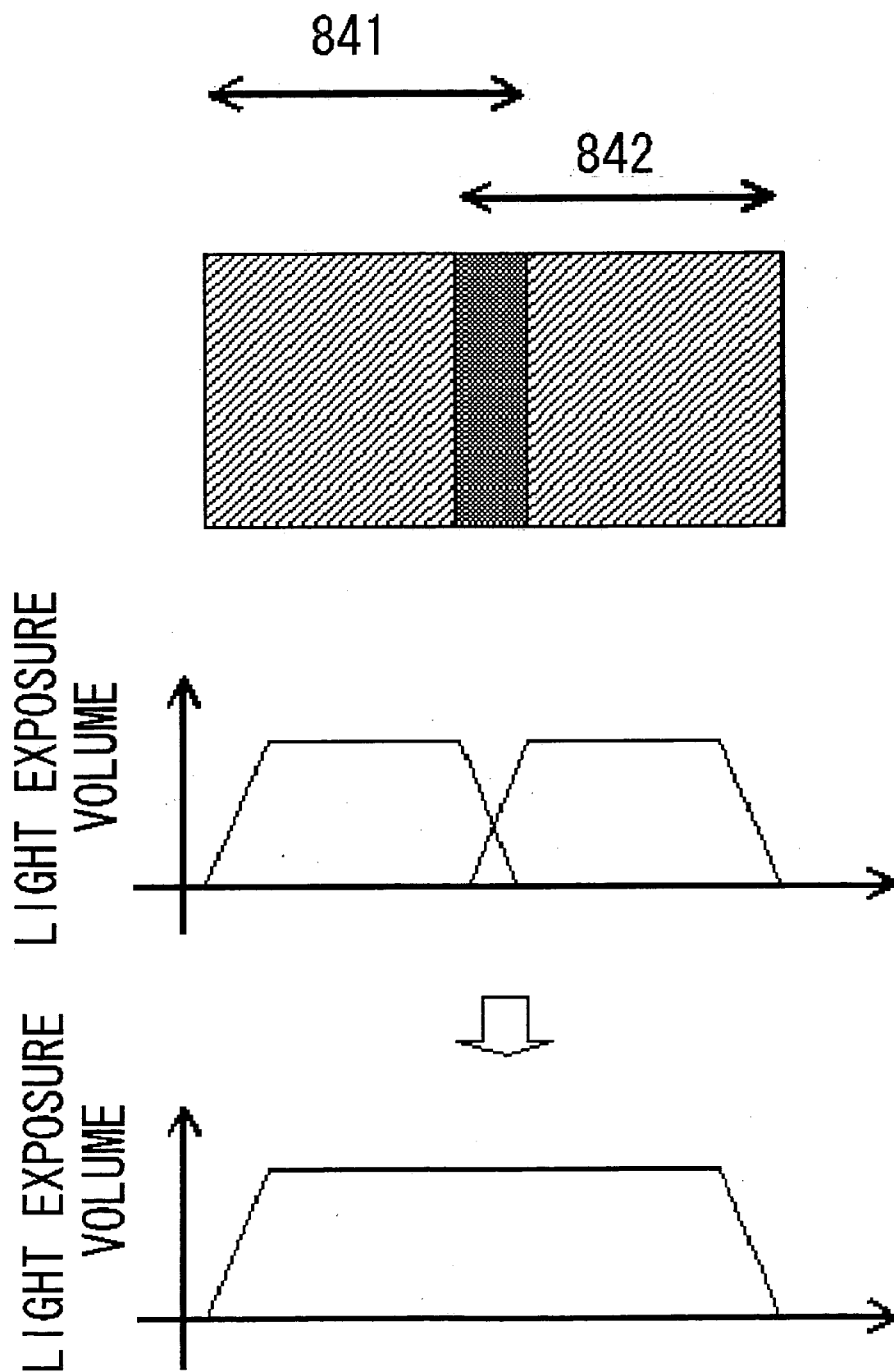


FIG . 9a PRIOR ART

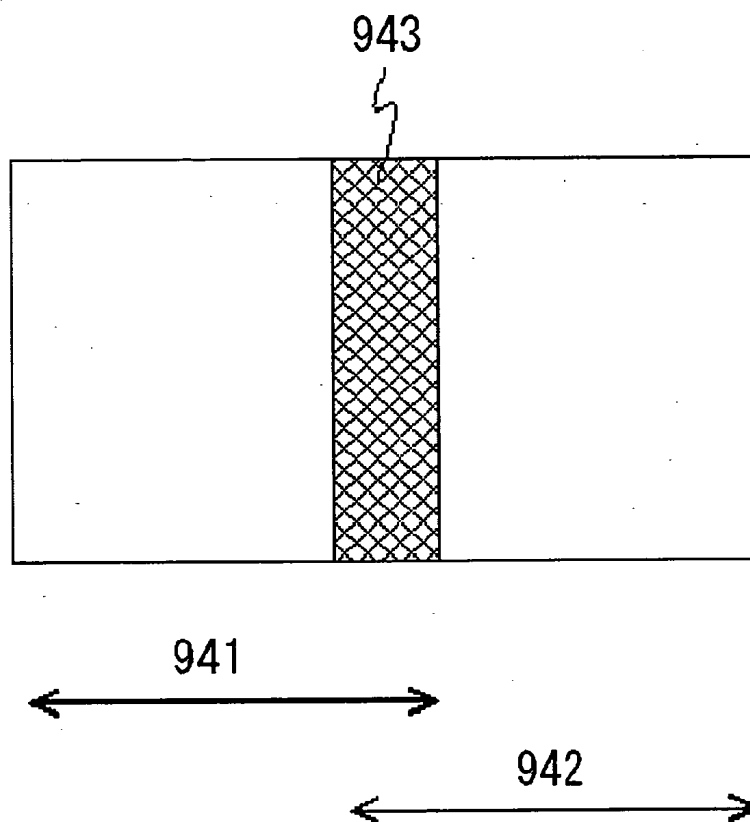
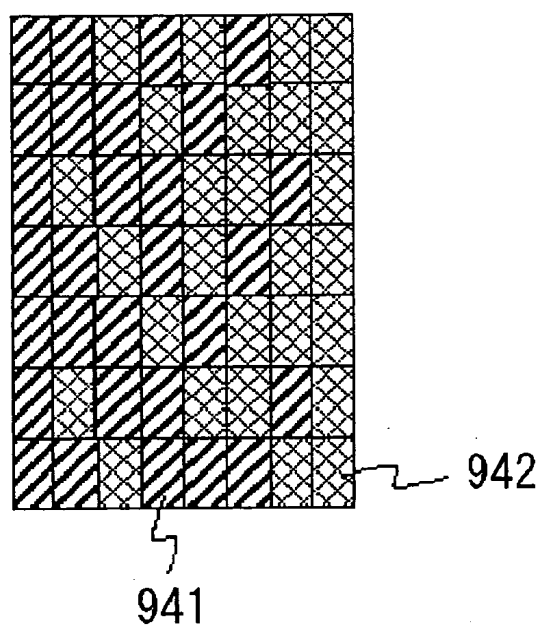


FIG . 9b PRIOR ART



MASK FOR LIGHT EXPOSURE AND METHOD FOR MANUFACTURING LIQUID CRYSTAL DISPLAY APPARATUS EMPLOYING SAME

FIELD OF THE INVENTION

[0001] This invention relates to a method for manufacturing a mask for light exposure and a liquid crystal display device employing the light exposure mask. More particularly, it relates to a mask for multi-domain light exposure in a photoresist process in forming a pattern on a substrate constituting a liquid crystal display device, and to a method for manufacturing the liquid crystal display device.

BACKGROUND OF THE INVENTION

[0002] In a manufacturing process for a thin-film transistor, abbreviated to TFT, as used in an active matrix liquid crystal display device, a batch light exposure system in which a TFT substrate is exposed to light at a time using a mirror projector type light exposure device, referred to herein as an aligner, and a multi-domain light exposure system, in which a TFT substrate is divided into plural domains for exposure to light using a lens type scan light exposure apparatus, referred to herein as a stepper, are nowadays in use.

[0003] Recently, there is an increasing demand for a larger size of a manufacturing apparatus for a liquid crystal display device in order to keep pace with the increasing size of the screen of the liquid crystal display device. As for a light exposure apparatus for a photoresist, an image frame is divided into plural domains, using a stepper, to effect light exposure from one domain to the next, whereby it is possible to cope with the increasing size of the image frame, even with a conventional light exposure apparatus. With this method, a light exposure shot system (**FIG. 8**) is used by a method shown in **FIG. 7**, in order that the volume of light exposure in the overlapping portions of junction areas of the plural domains will be uniform.

[0004] With this method, the optical system which exposes an end part of a reticle is provided with a blind **732** carrying a filter **731** presenting a gradient in transmittivity for smoothly changing the amount of light exposure at the junction of the boundary portions between shots of light exposure carried out in accordance with the multi-domain light exposure system. This produces moderate changes at the ends of the reticle, as indicated in a curve in a lower part of **FIG. 8**. The boundary portions are exposed to light in duplication to assure a uniform total light exposure volume.

[0005] However, the known system suffers from a drawback that the line of division is perceived at the time of display of the liquid crystal display device due to overlap deviation at the junction areas of the division or variations in illuminance of the exposure light. As a method for moderating the perceptibility of the division line, there is disclosed in Cited Reference 1 a method for complementary light exposure by plural neighboring masks.

[0006] This method is now explained with reference to **FIG. 9**. **FIG. 9a** shows a shot A **941** and a shot-B **942** neighboring to each other in the transverse direction and an area of superposition **943** of these two shots A **941** and B **942**. Referring to **FIG. 9b**, showing the area of superposition **943** to an enlarged scale, the shots are arranged in a random

number fashion so that a larger number of the shots are distributed in an area proximate to the area of specific shots, in such a manner that the difference in luminance is not perceived by not providing a boundary line.

Cited Reference 1

[0007] Publication of JP Patent Kokai Publication JP-P2000-180894A (paragraph number [0016], **FIGS. 9a** and **9b**).

SUMMARY OF THE DISCLOSURE

[0008] This method has a drawback that, while the boundary line becomes vague and imperceptible, the complementary light exposure leads to an amount of light exposure in the overlapping portion of light exposure which is relatively larger than that in the non-overlapping portion, due to bending over (diffraction) of the exposure light, thus producing the line width difference, with a result that, although the boundary line is imperceptible, only the overlapping area shows different illuminance. Thus there is much to be desired in the art.

[0009] It is an object of the present invention to provide a mask for light exposure by means of which boundary lines between different domains of the multi-domain light exposure system may not be perceived, and a method for producing a display device such as liquid crystal display employing such mask for light exposure.

[0010] According to an aspect of the present invention, there is provided a mask for light exposure. The mask has light shielding (masking) areas and light transmitting areas, wherein a plurality of first blocks having a preset pattern of light exposure and a plurality of second blocks not having a pattern for light exposure (i.e. having a pattern for masking) are formed in the same shape. The first and second blocks are arrayed in alternation with one another in both horizontal and transverse (i.e., x and y) directions. The first blocks of the mask for light exposure have a device pattern corresponding to at least one pixel of a display panel, e. g., liquid crystal panel. The first and second blocks are arrayed with a same pitch of repetition in alternation with one another in both the longitudinal and transverse directions.

[0011] According to a second aspect of the present invention, there is provided, e. g., liquid crystal display a method for manufacturing a display apparatus. The method comprises: providing a mask for light exposure composed of a plurality of first blocks of a preset pattern for light exposure and a plurality of second blocks not having a pattern for light exposure (i.e., a pattern for masking), and dividing a substrate, formed by arraying pixels in both the horizontal and transverse directions, into a plurality of rectangular domains of the same shape. Then the method comprises: carrying out a first light exposure operation for each of the rectangular domains, positioning the mask for light exposure relative to the substrate so that areas corresponding to the second blocks (not exposed to light by the first light exposure operation) are in register with the first blocks of the mask followed by carrying out second light exposure operation. To effect light exposure of the totality of pixels of the substrate, subsequent light exposure operations are carried out by repeating the first and second light exposure operations.

[0012] Further, the method is carried out so that the position of the mask for light exposure used for the second and the subsequent light exposure operations is shifted a length equal to a half the horizontal length and the transverse length, respectively, of the rectangular domains relative to the position of the mask for light exposure used for the first light exposure operation. In other words the shifting is carried out diagonally of a check block or the check pattern, preferably by registering a corner of a reticle pattern with a center of the previous exposed domain. The first and second blocks are arrayed a same pitch of repetition in alternation with one another in both the horizontal and transverse directions.

BRIEF DESCRIPTION OF THE DRAWINGS

[0013] FIG. 1 is a plan view of a reticle for light exposure used in a first embodiment of the present invention.

[0014] FIG. 2a is a plan view for illustrating a shooting layout of first light exposure shots using a reticle for light exposure and FIG. 2b is an enlarged plan view showing the boundary area of the light exposure shots.

[0015] FIG. 3a is a plan view for illustrating a shooting layout of second light exposure shots using a reticle for light exposure and FIG. 3b is an enlarged plan view showing the boundary area of the light exposure shots.

[0016] FIG. 4a is a plan view of a pattern of a TFT substrate for one pixel of the reticle for light exposure, and FIG. 4b is a cross-sectional view taken along line A-A' of FIG. 4a.

[0017] FIG. 5a shows how the second light exposure shot diminishes the difference in illuminance of the exposure light on the boundary area to the first light exposure shot, and FIG. 5b shows how the difference in illuminance of conventional light exposure shots directly presents itself on the boundary area.

[0018] FIGS. 6a, 6b and 6c are plan views of a layout of reticle for individual light exposure shots used in a second embodiment of the present invention.

[0019] FIG. 7 is a cross-sectional view showing a conventional method for light exposure in which the volume of light exposure of overlapping portions between two light exposure shots is uniform.

[0020] FIG. 8 illustrates the principle in which, in the method for light exposure shot shown in FIG. 7, the amounts of light exposure in two neighboring light exposure shots are made equal to each other.

[0021] FIGS. 9a and 9b show another conventional method for light exposure, where FIG. 9a is a plan view for illustrating the principle of diminishing the difference in light exposure amount on the boundary between neighboring light exposure shots, and FIG. 9b is an enlarged plan view showing the boundary between the light exposure shots of FIG. 9a.

PREFERRED EMBODIMENTS OF THE INVENTION

[0022] Referring to FIGS. 1 to 5, a first embodiment of the present invention is now explained. FIG. 1 depicts a plan view of a reticle for light exposure, as used in the present

invention. FIG. 2a depicts a plan view for illustrating a layout of the first light exposure shot by a reticle for light exposure, and FIG. 2a depicts an enlarged plan view of a boundary area of shots light exposure. FIG. 3a depicts a plan view (layout) for illustrating shooting manner of the second light exposure shot by a reticle for light exposure, and FIG. 3b depicts an enlarged plan view of a boundary area of the shots light exposure. FIG. 4a is a plan view of a TFT substrate pattern for one pixel of a reticle for light exposure, and FIG. 4b depicts a cross-sectional view of a liquid crystal panel taken along line A-A' of FIG. 4a. FIG. 5 depicts a graph for illustrating the manner of correction of the amount of light exposure of two neighboring shot areas by two light exposure shots.

[0023] Referring to the drawings, a shot area of a sole reticle 101 is designed so that plural light exposure domains 103 and plural light masking domains 104 are arrayed in alternation with one another (delta configuration) in horizontal and vertical directions, i.e., forming a check-like layout, as shown in FIG. 1.

[0024] Using this reticle 101, a display area of the active matrix substrate of a liquid crystal panel is exposed to light by plural shots, as shown in FIG. 2a. In this case, the light exposure shots are constructed so that, in the boundary area of four neighboring light exposure shots A, B, H and G, the light exposure areas 103 are not neighboring to one another, that is, a light masking area 104 is adjacent to four sides of the light exposure areas 103, while another light exposure areas 103 are positioned on an extension of diagonal lines of the given light exposure area 103, as shown in FIG. 2a., making up a check-like layout.

[0025] A second light exposure shot is then carried out in order to expose portions of the display area of the active matrix substrate which were light masking areas in the first light exposure shot, as shown in FIG. 3a. In this case, the light exposure area 103 of the second light exposure shot is arrayed so that the edge of light exposure area 103 of the first light exposure shot is not overlapped with the edge of the light exposure area 103 of the second light exposure shot. This exposes the portions of the display area which were the light masking area in the first light exposure shot, as shown in FIG. 3b.

[0026] With the above method, it is possible to eliminate the inconvenience of producing boundary lines in the boundary areas of the multi-domain light exposure to allow the manufacture of an active matrix substrate capable of displaying an image of high image quality. The light exposure system of the present embodiment, inclusive of pattern arrangement of a reticle, used in the light exposure system, is now explained.

[0027] The reticle 101, used for multi-domain light exposure, is provided with a rectangular patterning area 102, in the vicinity of a normally square-shaped quartz wafer, as shown in FIG. 1. In this patterning area 102, plural light exposure areas 103 and plural light masking areas 104 are arranged in alternation with one another making up a check-like pattern layout, as shown in FIG. 1. These light exposure areas 103 and light masking areas 104 are arranged in association with respective pixels in the display area. It is assumed that the display area is now exposed to light using this reticle 101.

[0028] By way of the first light exposure operation, the display area is exposed to light as the display area is

partitioned into plural shots, specifically, shots A, B, C . . . P, Q, N, M in this order, as shown in **FIG. 2a**. It is noted that light exposure shots are carried out so that the light exposure areas **103** and the light masking areas **104** are arranged in alternation with each other in the shot boundaries in both the horizontal and transverse (vertical) directions, in a matrix configuration, as shown in **FIG. 2a**.

[0029] The second light exposure shot is then carried out so that the areas which were the light exposure areas **103** and the light masking areas **104** are now the light masking areas **104** and the light exposure areas **103**, respectively. With this second light exposure shot, the shot positions are set so that the boundary of the light exposure area **103** in the first light exposure area is not overlapped with the boundary of the light exposure area **103** in the second light exposure area, and so that the centers of the shots A, B, G and H of the first light exposure shot is substantially coincident with the center of the reticle **101**. By exposing the display area to light in this manner, the first area of light exposure and the second area of light exposure are arranged in a delta fashion, i.e., making up a check-like pattern, as shown in **FIG. 3b**.

[0030] The method for manufacturing the liquid crystal display apparatus of the present embodiment, as applied to an active matrix liquid crystal display apparatus of the parallel electrical field type (IPS system) is now explained. The liquid crystal display apparatus of the IPS system is configured as shown in **FIG. 4**. It is noted that **FIG. 4a** depicts a plan view of one pixel of the active matrix substrate, and **FIG. 4b** depicts a cross-sectional view of a liquid crystal display panel, taken along line A-A' of **FIG. 4a**.

[0031] First, a gate electrode **312** of Cr and a common electrode (COM electrode) **313** are formed on a glass substrate **311**, and a gate insulating film **314** of silicon nitride is formed to overlie these electrodes. On the gate electrode **312** is formed a semiconductor film **315** of amorphous silicon, with the interposition of a gate insulating film **314**, for operating as an active layer for a transistor.

[0032] A drain electrode **316** of Cr and a source electrode **317** are formed so as to partially overlap with the pattern of the semiconductor film **315**. A protective film **318** of silicon nitride is formed so as to cover up all of these underlying layers. One pixel area is arranged between the common electrode **313**, disposed parallel to the source electrode **317**, and the source electrode **317**. On the surface of the active matrix substrate, on which a large number of unit pixels described above are arranged in a matrix configuration, there is formed an oriented film **320** having a rubbed surface.

[0033] The glass substrate **311** and a glass substrate **319** on the opposite face each other by the oriented films **320**, **321** and the oriented film forming surfaces, and a liquid crystal composition **322** is placed in-between.

[0034] A deflecting plate **323** is formed on an outer surface of the glass substrate **311**, while another deflecting plate **323** is formed on an outer surface of the opposite side glass substrate **319**. On a side directed to the liquid crystal composition **322** of the opposite glass substrate **319** are formed a color filter layer **324** and a light masking layer **325** in the same layer and are covered by a protective film **326** and the oriented film **321**. The light masking layer **325**, delimiting the color filter layer **324**, has its portion arranged over a thin-film transistor formed by a semiconductor film **315**.

[0035] If, with the above-described active matrix liquid crystal display apparatus, no electrical field is applied to the liquid crystal composition, the molecules of the liquid crystal are substantially parallel to one another in a direction of parallel extension of the source electrode **317** and the common electrode **313**, and are oriented homogeneously. That is, the liquid crystal molecules are oriented such that the direction of the long axis (optical axis) of the liquid crystal molecules is at an angle of not less than 45° and less than 90° with respect to the direction of the electrical field defined between the source electrode **317** and the common electrode **313**. Meanwhile, the glass substrate **311** and the opposite side glass substrate **319** are parallel to the orientation of the liquid crystal molecules. The dielectric constant anisotropy of the liquid crystal molecules is positive, in this case.

[0036] The manufacturing method of the present embodiment is used when forming an electrode pattern on a glass substrate, as an example.

[0037] The electrode pattern is formed by first forming a Cr film on the entire surface of a glass substrate, then forming a resist layer thereon and exposing the resist layer to light in accordance with a preset pattern followed by etching.

[0038] Upon exposing the resist layer to light, in the present embodiment, the glass substrate is partitioned into plural areas, as shown in **FIG. 2a**, and first light exposure is carried out. In the embodiment illustrated, a display zone is divided into 16 equal portions for shots A, B, . . . , M for light exposure, and shooting is carried out using a separate mask for the peripheral area around the display zone. The reticle used for this light exposure includes plural light exposure areas and plural light masking areas, arrayed in alternation with one another, in both the horizontal and transverse (vertical) directions, in a matrix configuration, with division of the matrix corresponding to one pixel or several pixels, as shown in **FIG. 1**.

[0039] The boundaries of the respective shots are such that the respective light exposure areas and the light masking areas of the shots A, B, H and G are adjacent to one another. The second light exposure then is carried out using a reticle of which the light exposure areas are located in register with the areas of the glass substrate corresponding to the light masking areas of the second light exposure. In other words, essentially a reversal pattern of that of the reticle at the first light exposure shot is used. It is noted that the second light exposure shots are carried out by placing the reticle so that the center of the first shots A, B, H and G is substantially in register with the center of the reticle, as shown in **FIG. 3a**. The result is that light exposure areas of the second light exposure are located in register with the portions of the glass substrate which were the light masking areas during the first light exposure (light masking area of **FIG. 2b**), so that the light exposed state is now at a state as shown in **FIG. 3b**.

[0040] In the similar manner, light exposure is carried out as the light exposure areas (patterns) of a reticle are positioned so that the centers of the first light exposure shots B, G, G and H are located substantially in register with the center of the reticle, as shown in **FIG. 3a**. Namely, a reversal pattern (reversal reticle in essence) of that of the reticle at the first light exposure shot is used at the second light exposure shot. The result is that light exposure is carried out so that

the areas of the second light exposure operation are located in register with the portions of the substrate which were the light masking areas in the first light exposure (light masking areas of **FIG. 2a**), as indicated in **FIG. 3b**.

[0041] As may be seen from the foregoing, if the method for light exposure of the present embodiment is followed, with the aid of the reticle of the present embodiment, the areas exposed to light with the respective shots in the boundary portions of the reticle exposed to light by multi-domain light exposure are not adjacent to each other, thus relaxing or eliminating the difference in illuminance among the respective shots, as shown in **FIG. 5b**.

[0042] More specifically, with the method in which the light exposure zone is divided into plural portions and each such portion is exposed to light only once, if there is any significant difference in illuminance between the light exposure shots A and H, the difference in illuminance is directly presented in the boundary area between the shots, as shown in **FIG. 5b**. With the present method in which not only the display zone is divided into plural domains, but also the light exposure operation for each domain is carried out by a plurality of light exposure operations, should there be any significant difference in light illuminance between the shots A and H of the first light exposure operation, only one half of the pixels in the light exposure shots A and H are affected by such difference in illuminance. In the second light exposure operation, no difference in illuminance is produced because the same shot is applied to the boundary portion of the light exposure shots A and H. This relaxes the difference in finish of the boundary portions of the shots from the illuminance on the shot boundary of the first light exposure, such differences becoming imperceptible to human eyes.

[0043] Referring to **FIG. 6**, the second embodiment of the present invention is now explained. In the present second embodiment, light exposure shots are carried out using the reticle of **FIG. 1** which is the same as that of the first embodiment. However, the present second embodiment differs from the first embodiment in shot map (i.e., shot layout).

[0044] Specifically, the shot A is carried out first, as shown in **FIG. 6** at a corner of the entire exposure area. The reticle then is shifted in the diagonal direction a length equal to a half the length of the diagonal line to carry out a shot a (**FIG. 6b**). The reticle then is shifted to a position directly below shot A to carry out a shot B, then shifted in the diagonal line a length equal to a half the diagonal line to carry out a shot b (**FIG. 6c**), and so forth, in order to carry out light exposure sequentially. It should be noted that, in an area of each current shot overlapping with an area of a directly previous shot, the light exposure area of the current shot is located in register with the light masking area of the previous shot. With the present method, since the shortest movement distance of the reticle from one shot to the next suffices, while the change in the illuminance of the light exposure, attendant on changes of the apparatus with lapse of time, is also small, the difference in illuminance from one shot to the next may be suppressed to a smaller value than in the light exposure method of the first embodiment.

[0045] The meritorious effects of the present invention are summarized as follows.

[0046] According to the present invention, the light exposure areas and the light masking areas in a sole reticle are

arranged in alternation to one another in both the horizontal and transverse (vertical) directions, and the substrate is exposed to light by multi-domain light exposure using this reticle. Since the substrate is exposed to light by multi-domain light exposure so that the respective areas of the reticle exposed to light with respective shots are not adjacent to one another in the boundary portions of the reticle, shifted for executing the respective shots, thus relaxing the difference in illuminance between the respective shots and the difference in finish of the boundary portions of the shots, such differences becoming imperceptible to human eyes.

[0047] It should be noted that other objects, features and aspects of the present invention will become apparent in the entire disclosure and that modifications may be done without departing the gist and scope of the present invention as disclosed herein and claimed as appended herewith.

[0048] Also it should be noted that any combination of the disclosed and/or claimed elements, matters and/or items may fall under the modifications aforementioned.

What is claimed is:

1. A mask for light exposure comprising light masking areas and light transmitting areas, wherein a plurality of first blocks having a preset pattern of light exposure and a plurality of second blocks as a pattern for masking are formed in a same shape,

said first blocks and said second blocks being arrayed in alternation with one another in both horizontal and transverse directions.

2. The mask for light exposure as defined in claim 1 wherein said first blocks have a device pattern corresponding to at least one pixel of a display panel.

3. The mask for light exposure as defined in claim 1 wherein said first and second blocks are arrayed at a same pitch of repetition in alternation with one another in both the horizontal and transverse directions.

4. The mask for light exposure as defined in claim 2 wherein said first and second blocks are arrayed at a same pitch of repetition in alternation with one another in both the horizontal and transverse directions, and said display panel comprises liquid display panel.

5. A method for manufacturing a display apparatus comprising:

providing a mask for light exposure composed of a plurality of first blocks having a preset pattern of light exposure and a plurality of second blocks as a pattern for masking,

dividing a substrate, formed by arraying pixels in both horizontal and transverse directions, into a plurality of rectangular domains of a same shape,

carrying out a first light exposure operation for each of said rectangular domains,

positioning said mask relative to said substrate so that areas, corresponding to the second blocks, of said rectangular domains not exposed to light by the first light exposure operation are in register with the first blocks of said mask, and

carrying out second light exposure operation.

6. The method for manufacturing a liquid crystal display apparatus as defined in claim 5

wherein the method is carried out by shifting the position of the mask for light exposure used for the second light exposure operation by a length equal to each a half a horizontal length and a transverse length of said rectangular domains relative to the position of the mask for light exposure used for said first light exposure operation.

7. The method as defined in claim 6, wherein said shifting is repeated for carrying out a light exposure operation subsequent to said second light exposure operation.

8. The method for manufacturing a liquid crystal display apparatus as defined in claim 5 wherein the first and second blocks are arrayed with a same pitch of repetition in alternation with one another in both the longitudinal and transverse directions.

9. A method for manufacturing a display apparatus comprising:

providing a mask for light exposure composed of a plurality of first blocks of a preset pattern for light exposure and a plurality of second blocks for masking,

dividing a substrate, formed by arraying pixels in both horizontal and transverse directions, into a plurality of rectangular domains of the same shape,

carrying out a first light exposure operation through the first blocks of said mask for each of said rectangular domains,

positioning said mask for light exposure relative to said substrate so that areas corresponding to the second blocks not exposed to light by the first light exposure operation are in register with the first blocks of said mask,

carrying out second light exposure operation, and

carrying out subsequent light exposure operations by repeating said first and second light exposure operations to effect light exposure of the totality of pixels of said substrate.

10. The method as defined in claim 9, wherein said blocks have a device pattern corresponding to at least one pixel of a display panel.

11. The method as defined in claim 9, wherein said first and second blocks are arrayed at a same pitch of repetition in alternation with one another in both the horizontal and transverse directions.

12. The method as defined in claim 9, wherein said first blocks and said second blocks are arrayed in said mask making up a check pattern.

13. The method as defined in claim 12, wherein said first blocks and second blocks are arrayed so that, when repeated in at least one of horizontal and transverse directions, any array is ended by a block which is a reversal of a light exposing block or masking block.

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专利名称(译)	用于曝光的掩模和制造采用该掩模的液晶显示装置的方法		
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摘要(译)

鞋底掩模版中的曝光区域103和光掩模区域104在纵向和横向上彼此交替排列。使用该掩模版通过多畴曝光使基板曝光，使得掩模版的各个区域用各自的曝光量A至B，B至C曝光。。。，N至M在为了执行各个发射而移动的分划板的边界部分中彼此不相邻，因此缓和了各个发射之间的照度差和发射的边界部分的完成度的差异，在显示液晶显示装置时人眼不会感觉到。

